Application/Control No. Applicant(s)/Patent Under Reexamination 09/839,972 BODNAR ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Huy Q. Phan 2617 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-2002/0164977 A1 11-2002 Link II et al. Α 455/414 US-2002/0082001 A1 06-2002 Tanaka et al. В 455/414 07-2005 С US-6,919,923 B1 Tanaka et al. 348/220.1 US-2004/0171371 A1 09-2004 Paul, Glenn D 455/414.4 US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Classification Name Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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